Application/Control No. Applicant(s)/Patent Under Reexamination 09/943,859 SIN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tianjie Chen 2652 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY 04-2002 Redon et al. 360/324.2 US-6,381,107 В US-Ç US-D US-Ε US-US-F US-G US-Н ı US-US-J US-US-

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